



August 2001
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74VCX32245

Low Voltage 32-Bit Bidirectional Transceiver with 3.6V Tolerant Inputs and Outputs (Preliminary)

General Description

The VCX32245 contains thirty-two non-inverting bidirectional buffers with 3-STATE outputs and is intended for bus oriented applications. The device is byte controlled. Each byte has separate 3-STATE control inputs which can be shorted together for full 32-bit operation. The $\overline{T/R}$ inputs determine the direction of data flow through the device. The \overline{OE} inputs disable both the A and B ports by placing them in a high impedance state.

The 74VCX32245 is designed for low voltage (1.65V to 3.6V) V_{CC} applications with I/O compatibility up to 3.6V.

The 74VCX32245 is fabricated with an advanced CMOS technology to achieve high speed operation while maintaining low CMOS power dissipation.

Features

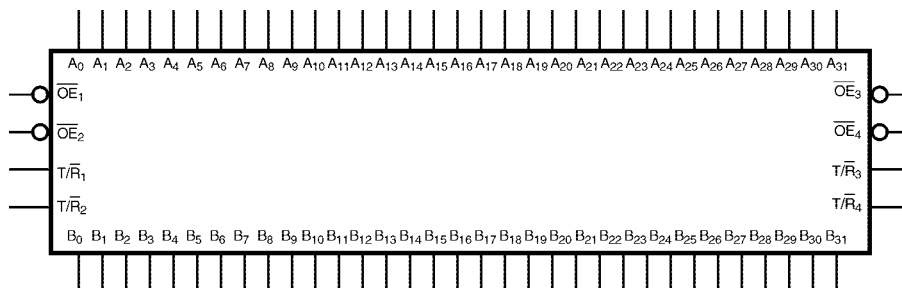
- 1.65V–3.6V V_{CC} supply operation
 - 3.6V tolerant inputs and outputs
 - t_{PD}
 - 2.5 ns max for 3.0V to 3.6V V_{CC}
 - 3.0 ns max for 2.3V to 2.7V V_{CC}
 - 6.0 ns max for 1.65V to 1.95V V_{CC}
 - Power-down high impedance inputs and outputs
 - Supports live insertion/withdrawal (Note 1)
 - Static Drive (I_{OH}/I_{OL})
 - ± 24 mA @ 3.0V V_{CC}
 - ± 18 mA @ 2.3V V_{CC}
 - ± 6 mA @ 1.65V V_{CC}
 - Uses patented noise/EMI reduction circuitry
 - Latchup performance exceeds 300 mA
 - ESD performance:
 - Human body model > 2000V
 - Machine model >200V
 - Packaged in plastic Fine-Pitch Ball Grid Array (FBGA)
- Note 1:** To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pull-up resistor; the minimum value of the resistor is determined by the current-sourcing capability of the driver.

Ordering Code:

Order Number	Package Number	Package Description
74VCX32245GX (Note 2)	BGA96A	96-Ball Fine-Pitch Ball Grid Array (FBGA), JEDEC MO-205, 5.5mm Wide [Tape and Reel]

Note 2: BGA package available in Tape and Reel only.

Logic Symbol



74VCX32245 Low Voltage 32-Bit Bidirectional Transceiver with 3.6V Tolerant Inputs and Outputs (Preliminary)

Absolute Maximum Ratings (Note 3)		Recommended Operating Conditions (Note 5)	
Supply Voltage (V_{CC})	-0.5V to +4.6V	Power Supply	
DC Input Voltage (V_I)	-0.5V to +4.6V	Operating	1.65V to 3.6V
Output Voltage (V_O)		Data Retention Only	1.2V to 3.6V
Outputs 3-STATE	-0.5V to +4.6V	Input Voltage	-0.3V to 3.6V
Outputs Active (Note 4)	-0.5 to $V_{CC} + 0.5V$	Output Voltage (V_O)	
DC Input Diode Current (I_{IK}) $V_I < 0V$	-50 mA	Output in Active States	0V to V_{CC}
DC Output Diode Current (I_{OK})		Output in 3-STATE	0.0V to 3.6V
$V_O < 0V$	-50 mA	Output Current in I_{OH}/I_{OL}	
$V_O > V_{CC}$	+50 mA	$V_{CC} = 3.0V$ to $3.6V$	± 24 mA
DC Output Source/Sink Current (I_{OH}/I_{OL})	± 50 mA	$V_{CC} = 2.3V$ to $2.7V$	± 18 mA
DC V_{CC} or Ground Current per Supply Pin (I_{CC} or Ground)	± 100 mA	$V_{CC} = 1.65V$ to $2.3V$	± 6 mA
Storage Temperature Range (T_{STG})	-65°C to +150°C	Free Air Operating Temperature (T_A)	-40°C to +85°C
		Minimum Input Edge Rate ($\Delta t/\Delta V$)	
		$V_{IN} = 0.8V$ to $2.0V$, $V_{CC} = 3.0V$	10 ns/V

Note 3: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the "Electrical Characteristics" table are not guaranteed at the Absolute Maximum Ratings. The Recommended Operating Conditions tables will define the conditions for actual device operation.

Note 4: I_O Absolute Maximum Rating must be observed.

Note 5: Floating or unused pin (inputs or I/O's) must be held HIGH or LOW.

DC Electrical Characteristics (2.7V < V_{CC} ≤ 3.6V)

Symbol	Parameter	Conditions	V_{CC} (V)	Min	Max	Units
V_{IH}	HIGH Level Input Voltage		2.7-3.6	2.0		V
V_{IL}	LOW Level Input Voltage		2.7-3.6		0.8	V
V_{OH}	HIGH Level Output Voltage	$I_{OH} = -100 \mu A$ $I_{OH} = -12 \text{ mA}$ $I_{OH} = -18 \text{ mA}$ $I_{OH} = -24 \text{ mA}$	2.7-3.6 2.7 3.0 3.0	$V_{CC} - 0.2$ 2.2 2.4 2.2		V
V_{OL}	LOW Level Output Voltage	$I_{OL} = 100 \mu A$ $I_{OL} = 12 \text{ mA}$ $I_{OL} = 18 \text{ mA}$ $I_{OL} = 24 \text{ mA}$	2.7-3.6 2.7 3.0 3.0		0.2 0.4 0.4 0.55	V
I_I	Input Leakage Current	$0V \leq V_I \leq 3.6V$	2.7-3.6		± 5.0	μA
I_{OZ}	3-STATE Output Leakage	$0V \leq V_O \leq 3.6V$ $V_I = V_{IH}$ or V_{IL}	2.7-3.6		± 10	μA
I_{OFF}	Power Off Leakage Current	$0V \leq (V_I, V_O) \leq 3.6V$	0		10	μA
I_{CC}	Quiescent Supply Current	$V_I = V_{CC}$ or GND $V_{CC} \leq (V_I, V_O) \leq 3.6V$ (Note 6)	2.7-3.6 2.7-3.6		40 ± 40	μA
ΔI_{CC}	Increase in I_{CC} per Input	$V_{IH} = V_{CC} - 0.6V$	2.7-3.6		750	μA

Note 6: Outputs disabled or 3-STATE only.

DC Electrical Characteristics (2.3V ≤ V _{CC} ≤ 2.7V)						
Symbol	Parameter	Conditions	V _{CC} (V)	Min	Max	Units
V _{IH}	HIGH Level Input Voltage		2.3-2.7	1.6		V
V _{IL}	LOW Level Input Voltage		2.3-2.7		0.7	V
V _{OH}	HIGH Level Output Voltage	I _{OH} = -100 μA I _{OH} = -6 mA I _{OH} = -12 mA I _{OH} = -18 mA	2.3-2.7 2.3 2.3 2.3	V _{CC} - 0.2 2.0 1.8 1.7		V
V _{OL}	LOW Level Output Voltage	I _{OL} = 100 μA I _{OL} = 12 mA I _{OL} = 18 mA	2.3-2.7 2.3 2.3		0.2 0.4 0.6	V
I _I	Input Leakage Current	0 ≤ V _I ≤ 3.6V	2.3-2.7		±5.0	μA
I _{OZ}	3-STATE Output Leakage	0 ≤ V _O ≤ 3.6V V _I = V _{IH} or V _{IL}	2.3-2.7		±10	μA
I _{OFF}	Power Off Leakage Current	0 ≤ (V _I , V _O) ≤ 3.6V	0		10	μA
I _{CC}	Quiescent Supply Current	V _I = V _{CC} or GND V _{CC} ≤ (V _I , V _O) ≤ 3.6V (Note 7)	2.3-2.7 2.3-2.7		40 ±40	μA
Note 7: Outputs disabled or 3-STATE only.						
DC Electrical Characteristics (1.65V ≤ V _{CC} < 2.3V)						
Symbol	Parameter	Conditions	V _{CC} (V)	Min	Max	Units
V _{IH}	HIGH Level Input Voltage		1.65-2.3	0.65 × V _{CC}		V
V _{IL}	LOW Level Input Voltage		1.65-2.3		0.35 × V _{CC}	V
V _{OH}	HIGH Level Output Voltage	I _{OH} = -100 μA I _{OH} = -6 mA	1.65-2.3 1.65	V _{CC} - 0.2 1.25		V
V _{OL}	LOW Level Output Voltage	I _{OL} = 100 μA I _{OL} = 6 mA	1.65-2.3 1.65		0.2 0.3	V
I _I	Input Leakage Current	0 ≤ V _I ≤ 3.6V	1.65-2.3		±5.0	μA
I _{OZ}	3-STATE Output Leakage	0 ≤ V _O ≤ 3.6V V _I = V _{IH} or V _{IL}	1.65-2.3		±10	μA
I _{OFF}	Power Off Leakage Current	0 ≤ (V _I , V _O) ≤ 3.6V	0		10	μA
I _{CC}	Quiescent Supply Current	V _I = V _{CC} or GND V _{CC} ≤ (V _I , V _O) ≤ 3.6V (Note 8)	1.65-2.3 1.65-2.3		40 ±40	μA
Note 8: Outputs disabled or 3-STATE only.						

AC Electrical Characteristics (Note 9)								
Symbol	Parameter	T _A = -40°C to +85°C, C _L = 30 pF, R _L = 500Ω						Units
		V _{CC} = 3.3V ± 0.3V		V _{CC} = 2.5 ± 0.2V		V _{CC} = 1.8V ± 0.15V		
		Min	Max	Min	Max	Min	Max	
t _{PHL} , t _{PLH}	Prop Delay	0.8	2.5	1.0	3.0	1.5	6.0	ns
t _{PZL} , t _{PZH}	Output Enable Time	0.8	3.8	1.0	4.9	1.5	9.3	ns
t _{PLZ} , t _{PHZ}	Output Disable Time	0.8	3.7	1.0	4.2	1.5	7.6	ns
Note 9: For C _L = 50pF, add approximately 300ps to the AC maximum specification.								
Dynamic Switching Characteristics								
Symbol	Parameter	Conditions	V _{CC} (V)	T _A = +25°C	Units			
				Typical				
V _{OLP}	Quiet Output Dynamic Peak V _{OL}	C _L = 30 pF, V _{IH} = V _{CC} , V _{IL} = 0V	1.8	0.25	V			
			2.5	0.6				
			3.3	0.8				
V _{OLV}	Quiet Output Dynamic Valley V _{OL}	C _L = 30 pF, V _{IH} = V _{CC} , V _{IL} = 0V	1.8	-0.25	V			
			2.5	-0.6				
			3.3	-0.8				
V _{OHV}	Quiet Output Dynamic Valley V _{OH}	C _L = 30 pF, V _{IH} = V _{CC} , V _{IL} = 0V	1.8	1.5	V			
			2.5	1.9				
			3.3	2.2				
Capacitance								
Symbol	Parameter	Conditions	T _A = +25°C	Units				
C _{IN}	Input Capacitance	V _{CC} = 1.8V, 2.5V, or 3.3V, V _I = 0V or V _{CC}	6	pF				
C _{I/O}	Output Capacitance	V _I = 0V, or V _{CC} , V _{CC} = 1.8V, 2.5V or 3.3V	7	pF				
C _{PD}	Power Dissipation Capacitance	V _I = 0V or V _{CC} , F = 10 MHz V _{CC} = 1.8V, 2.5V or 3.3V	20	pF				

AC Loading and Waveforms

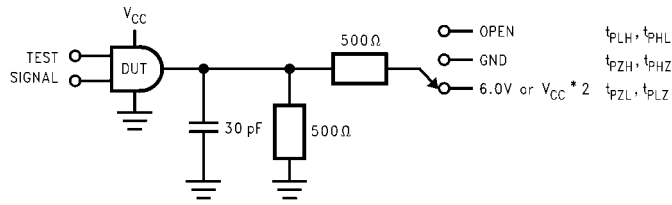


FIGURE 1. AC Test Circuit

TEST	SWITCH
t_{PLH}, t_{PHL}	Open
t_{PZL}, t_{PLZ}	6V at $V_{CC} = 3.3 \pm 0.3V$; $V_{CC} \times 2$ at $V_{CC} = 2.5 \pm 0.2V; 1.8V \pm 0.15V$
t_{PZH}, t_{PHZ}	GND

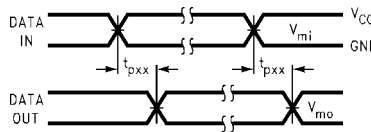


FIGURE 2. Waveform for Inverting and Non-inverting Functions

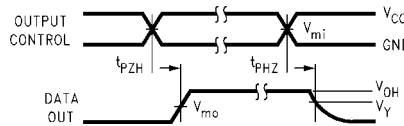


FIGURE 3. 3-STATE Output High Enable and Disable Times for Low Voltage Logic

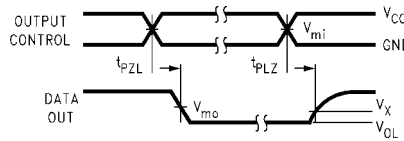
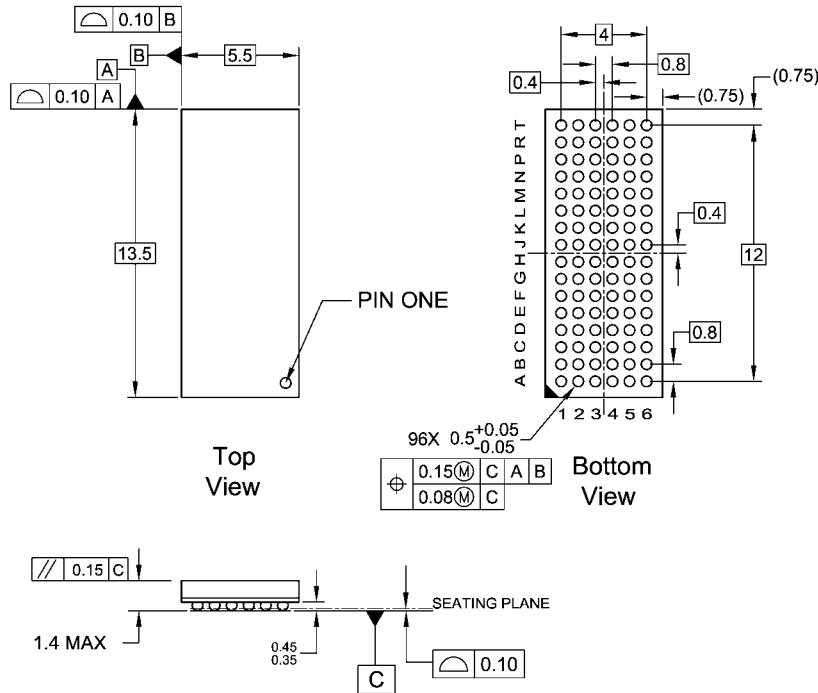


FIGURE 4. 3-STATE Output Low Enable and Disable Times for Low Voltage Logic

Symbol	V_{CC}		
	$3.3V \pm 0.3V$	$2.5V \pm 0.2V$	$1.8V \pm 0.15V$
V_{mi}	1.5V	$V_{CC}/2$	$V_{CC}/2$
V_{mo}	1.5V	$V_{CC}/2$	$V_{CC}/2$
V_X	$V_{OL} + 0.3V$	$V_{OL} + 0.15V$	$V_{OL} + 0.15V$
V_Y	$V_{OH} - 0.3V$	$V_{OH} - 0.15V$	$V_{OH} - 0.15V$

Physical Dimensions inches (millimeters) unless otherwise noted



NOTES:

- A. THIS PACKAGE CONFORMS TO JEDEC M0-205
- B. ALL DIMENSIONS IN MILLIMETERS
- C. LAND PATTERN RECOMMENDATION: NSMD (Non Solder Mask Defined)
.35MM DIA PADS WITH A SOLDERMASK OPENING OF .45MM CONCENTRIC TO PADS
- D. DRAWING CONFORMS TO ASME Y14.5M-1994

BGA96ArevE

**96-Ball Fine-Pitch Ball Grid Array (FBGA), JEDEC MO-205, 5.5mm Wide
Package Number BGA96A**

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